Search Notes		

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/773,550	NAKANO ET AL.	
•	Examiner	Art Unit	
	Chongshan Chen	2162	

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	SEARCHED			
Class	Subclass	Date	Examiner	
707	6	9/17/2005	cc	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
PALM	9/17/2005	cc
EAST search (USPAT, US-PGPUB, IBM_TDB)	9/17/2005	cc